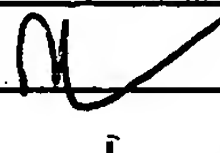
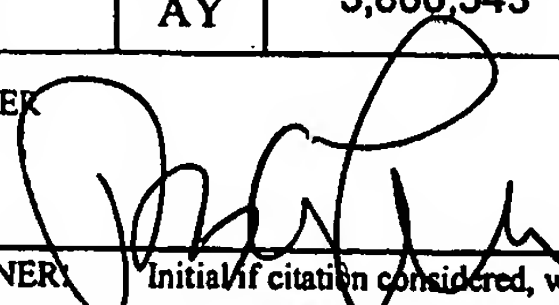
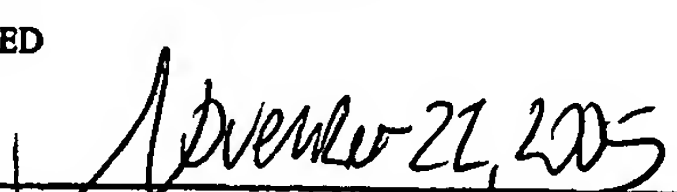

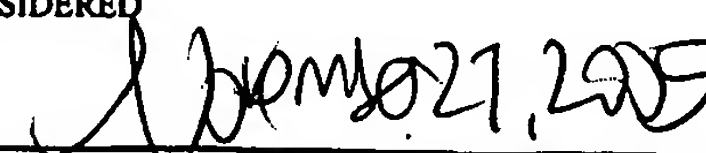


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U.S. PATENT DOCUMENTS							
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	AA	2,567,016	09/04/1951	Gessler et al.	260	45.5	
	AB	3,149,178	09/15/1964	Hamilton et al.	260	683.9	
	AC	3,201,364	08/17/1965	Salzer	260	33.6	
	AD	3,228,896	01/11/1966	Canterino	260	2.5	
	AE	3,235,529	02/15/1966	Nagle	260	33.6	
	AF	3,239,478	03/08/1966	Harlan, Jr.	260	27	
	AG	3,281,390	10/25/1966	O'Leary, Jr.	260	33.6	
	AH	3,299,568	01/24/1967	Tobolsky	47	9	
	AI	3,308,086	03/07/1967	Wartman	260	31.6	
	AJ	3,318,835	05/09/1967	Hagemeyer, Jr. et al.	161	226	
	AK	3,338,778	08/29/1967	Hutchins et al.	260	33.2	
	AL	3,361,702	01/02/1968	Wartman et al.	264	331	
	AM	3,415,925	12/10/1968	Marans	260	31.2	
	AN	3,437,627	04/08/1969	Gude et al.	424	63	
	AO	3,439,088	04/15/1969	Edman	260	32.6	
	AP	3,464,949	09/02/1969	Wartman et al.	260	33.4	
	AQ	3,475,368	10/28/1969	Metz	262	33.4	
	AR	3,536,796	10/27/1970	Rock	264	49	
	AS	3,541,039	11/17/1970	Whiton	260	31.6	
	AT	3,563,934	02/16/1971	Burnett	260	30.4	
AU	3,752,779	08/14/1973	Maciejewski	260	23H		
AV	3,818,105	06/18/1974	Coopersmith et al.	424	358		
AW	3,821,148	06/28/1974	Makowski et al.	260	30.62		
AX	3,839,261	10/01/1974	Aronoff et al.	260	31.8F		
AY	3,860,543	01/14/1975	Masuda et al.	260	28.5AV		

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m	AZ	3,925,504	12/09/1975	Koleske et al.	260	823	
	BA	3,925,947	12/16/1975	Meyers et al.	52	208	
	BB	3,945,975	03/23/1976	Strack	260	33.6A Q	
	BC	3,988,276	10/26/1976	Kutch et al.	260	24	
	BD	4,006,115	02/01/1977	Elbert	260	31.8 N	
	BE	4,010,127	03/01/1977	Taka et al.	260	31.8 N	
	BF	4,061,805	12/06/1977	Thompson et al.	260	23 R	
	BG	4,063,002	12/13/1977	Wilson, Jr.	428	411	
	BH	4,073,782	02/14/1978	Kishi et al.	260	23 H	
	BI	4,092,282	05/30/1978	Callan	260	26	
	BJ	4,094,850	06/13/1978	Morgan et al.	260	31.8 P Q	
	BK	4,104,216	08/01/1978	Clampitt	260	23 A R	
	BL	4,110,185	08/29/1978	Williams et al.	204	159.2	
	BM	4,118,359	10/03/1978	Brenner	260	30.8 R	
	BN	4,118,362	10/03/1978	Makowski et al.	260	32.6 A	
	BO	4,131,587	12/26/1978	Brenner	260	27 R	
	BP	4,132,698	01/02/1979	Gessler et al.	260	33.6 A Q	
	BQ	4,136,072	01/23/1979	Ladish et al.	260	27 R	
	BR	4,138,378	02/06/1979	Doss	260	27 B B	
	BT	4,147,831	04/03/1979	Balint	428	356	
BU	4,153,582	05/08/1979	Puffr et al.	252	511		
BV	4,153,588	05/08/1979	Makowski et al.	260	23.5 A		
BW	4,153,594	05/08/1979	Wilson, Jr.	260	31.8 R		
BX	4,154,712	05/15/1979	Lee, Jr.	260	29.1 R		
BY	4,154,244	05/15/1979	Becker et al.	428	342 B		
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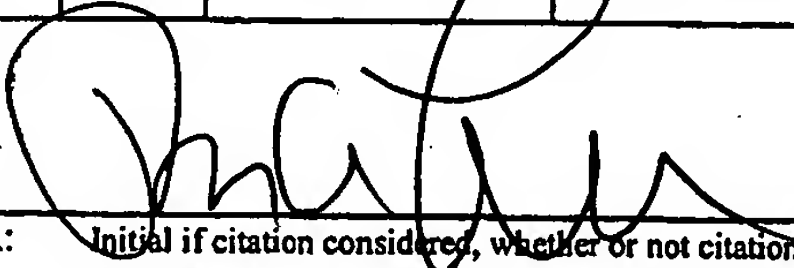
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<i>h</i>	CA	4,157,992	06/12/1979	Lundberg et al.	260	23.5A	
<i>l</i>	CB	4,166,057	08/28/1979	Takemori	260	33.6RQ	
	CC	4,169,822	10/02/1979	Kutch et al.	260	27BB	
	CD	4,170,586	10/09/1979	Clampitt et al.	260	33.6RQ	
	CE	4,175,069	11/20/1979	Brenner	260	32.6A	
	CF	4,189,411	02/19/1980	Haaf	260	27R	
	CG	4,210,570	07/01/1980	Trotter et al.	260	33.6A	
	CH	4,221,887	09/09/1980	Brenner et al.	525	332	
	CI	4,229,337	10/21/1980	Brenner	260	32.6A	
	CJ	4,237,083	12/02/1980	Young et al.	264	41	
	CK	4,274,932	06/23/1981	Williams et al.	204	19.2	
	CL	4,288,358	09/08/1981	Trotter et al.	260	31.8M	
	CM	4,288,480	09/08/1981	Grzywinski et al.	428	40	
	CO	4,289,668	09/15/1981	Li	260	33AR	
	CP	4,311,628	01/19/1982	Abdou-Sabet et al.	260	33.6AQ	
	CQ	4,322,336	03/30/1982	Machurat et al.	524	104	
	CS	4,325,850	04/20/1982	Mueller	524	228	
	CT	4,327,007	04/27/1982	Vanderkooi, Jr. et al.	524	315	
	CU	4,335,026	06/15/1982	Balinh	524	271	
	CV	4,335,034	06/15/1982	Zuckerman et al.	524	423	
	CW	4,340,513	07/20/1982	Moteki et al.	524	13	
	CX	4,347,332	08/31/1982	Odorzynski et al.	524	169	
	CY	4,352,823	10/05/1982	Cherukuri et al.	426	5	
	CZ	4,369,284	01/18/1983	Chen	524	476	
	DA	4,379,169	04/05/1983	Reggio et al.	426	3	
	DB	4,387,108	06/07/1983	Koch et al.	426	4	
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M	DC	4,399,248	08/16/1983	Singh et al.	524	205	
	DD	4,399,251	08/16/1983	Lee	524	481	
	DE	4,403,005	09/06/1983	Nevins et al.	428	48	
	DF	4,403,007	09/06/1983	Coughlin	428	95	
	DG	4,409,345	10/11/1983	Moteki et al.	524	13	
	DH	4,434,258	02/28/1984	Schumacher et al.	524	13	
	DI	4,438,228	03/20/1984	Schenck	524	109	
	DJ	4,438,229	03/20/1984	Fujimori et al.	524	109	
	DK	4,440,829	04/03/1984	Gerace et al.	428	343	
	DL	4,450,250	05/22/1984	McConnell et al.	524	141	
	DM	4,452,820	06/05/1984	D'Amelia et al.	426	3	
	DN	4,459,311	07/10/1984	DeTora et al.	426	3	
	DO	4,460,729	07/17/1984	Books	524	394	
	DP	4,467,065	08/21/1984	Williams et al.	524	296	
	DQ	4,469,770	09/04/1984	Nelson	428	110	
	DR	4,497,926	02/05/1985	Toy	524	271	
	DS	4,504,604	03/12/1985	Pilkington et al.	523	167	
	DT	4,518,615	05/21/1985	Cherukuri et al.	426	4	
	DU	4,529,666	07/16/1985	Salzburg et al.	428	475.8	
	DV	4,532,305	07/30/1985	Dickinson	525	390	
	DW	4,536,537	08/20/1985	Klingensmith et al.	524	481	
	DX	4,542,053	09/17/1985	Nevins et al.	428	48	
	DY	4,551,507	11/05/1985	Haylock et al.	525	347	
	DZ	4,552,801	11/12/1985	Odorzynski et al.	428	220	
	EA	4,579,901	04/01/1986	Allen et al.	524	284	
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	EC	4,616,052	10/07/1986	Habibullah	524	104	
	ED	4,645,791	02/24/1987	Theodore et al.	524	420	
	EE	4,659,757	04/21/1987	Okamoto et al.	523	436	
	EF	4,663,220	05/05/1987	Wisneski et al.	428	221	
	EG	4,666,959	05/19/1987	Weissberger et al.	523	137	
	EH	4,666,968	05/19/1987	Downey et al.	524	296	
	EI	4,670,341	06/02/1987	Lundsager	428	372	
	EJ	4,684,682	08/04/1987	Lee, Jr.	524	141	
	EK	4,703,078	10/27/1987	Maehara et al. MAEHARA et al.	524	476	
	EL	4,749,734	06/07/1988	Williams et al.	524	102	
	EM	4,745,143	05/17/1988	Mason et al.	524	98	
	EN	4,746,388	05/24/1988	Inaba et al.	524	102	
	EO	4,764,535	08/16/1988	Leicht	521	51	
	EP	4,772,657	09/20/1988	Akiyama et al.	524	504	
	EQ	4,774,277	09/27/1988	Janac et al.	524	474	
	ER	4,814,375	03/21/1989	Esposito	524	505	
	ES	4,824,891	04/25/1989	Laurent et al.	524	264	
	ET	4,833,172	05/23/1989	Schwarz et al.	521	621	
	EU	4,833,195	05/23/1989	Adur et al.	524	528	
	EV	4,840,988	06/20/1989	Nakayama et al.	524	476	
	EW	4,845,137	07/04/1989	Williams et al.	524	108	
	EX	4,914,145	04/03/1990	Tohdoh et al.	524	285	
	EY	4,919,992	04/24/1990	Blundell et al.	428	131	
	EZ	4,939,040	07/03/1990	Oreglia et al.	428	518	
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M	FA	4,952,457	08/28/1990	Cartier et al.	428	425.6	
	FB	4,957,958	09/18/1990	Schleifstein	524	169	
	FC	4,959,285	09/25/1990	Hoffmann	430	11	
	FD	4,959,396	09/25/1990	Yankov et al.	521	61	
	FE	4,959,402	09/25/1990	Williams et al.	524	99	
	FF	4,960,820	10/02/1990	Hwo	524	528	
	FG	4,995,884	02/26/1991	Ross et al.	8	115.6	
	FH	4,996,094	02/26/1991	Dutt	428	212	
	FI	5,026,756	06/25/1991	Arendt	524	293	
	FJ	5,028,647	07/02/1991	Haylock et al.	524	290	
	FK	5,080,942	01/14/1992	Yau	428	34.9	
	FL	5,091,454	02/25/1992	Arendt	524	293	
	FM	5,093,197	03/03/1992	Howard et al.	428	372	
	FN	5,106,899	04/21/1992	Maresca	524	372	
	FO	5,116,626	05/26/1992	Synosky et al.	426	3	
	FP	5,124,384	06/23/1992	Goldstein	524	169	
	FQ	5,149,736	09/22/1992	Gamarra	524	490	
	FR	5,171,908	12/15/1992	Rudnick	525	255	
	FS	5,173,317	12/22/1992	Hartman et al.	426	6	
	FT	5,206,276	04/27/1993	Lee, Jr.	524	151	
FU	5,230,843	07/27/1993	Howard et al.	264	41		
FV	5,231,128	07/27/1993	Nakata et al.	524	445		
FW	5,238,735	08/24/1993	Nagou et al.	428	304.4		
FX	5,250,628	10/05/1993	Seguela et al.	525	210		
FY	5,256,717	10/26/1993	Stauffer et al.	524	293		
FZ	5,258,419	11/02/1993	Rolando et al.	522	109		

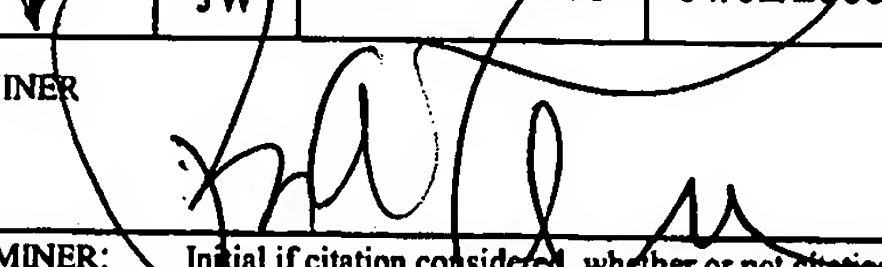
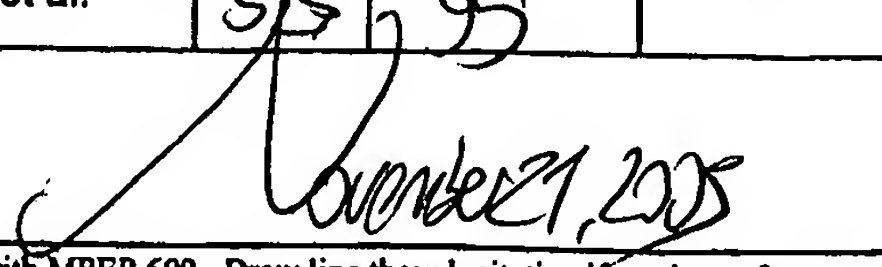
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	GB	5,278,220	01/11/1994	Vermeire et al.	524	490	
	GC	5,286,500	02/15/1994	Synosky et al.	426	3	
	GD	5,290,886	03/01/1994	Ellul	524	515	
	GE	5,308,904	05/03/1994	Fujii et al.	524	232	
	GF	5,312,856	05/17/1994	Hert et al.	524	297	
	GG	5,324,580	06/28/1994	Allan et al.	442	361	
	GH	5,356,709	10/18/1994	Woo et al.	428	376	
	GI	5,356,948	10/18/1994	Payne, Jr. et al.	522	75	
	GJ	5,356,986	10/18/1994	Stewart et al.	524	462	
	GK	5,376,716	12/27/1994	Nayak et al.	524	295	
	GL	5,389,711	02/14/1995	Westbrook et al.	524	288	
	GM	5,397,832	03/14/1995	Ellul Yoshida et al.	524	515	
	GN	5,409,041	04/25/1995	Yoshida et al.	138	30	
	GO	5,424,080	06/13/1995	Synosky et al.	426	3	
	GP	5,437,877	08/01/1995	Synosky et al.	426	3	
	GQ	5,442,004	08/15/1995	Sutherland et al.	524	140	
	GR	5,459,193	10/17/1995	Anderson et al.	524	505	
	GS	5,462,754	10/31/1995	Synosky et al.	426	4	
	GT	5,462,981	10/31/1995	Bastioli et al.	524	47	
	GU	5,489,646	02/06/1996	Tatman et al.	524	848	
	GV	5,492,943	02/20/1996	Stempel	523	111	
	GW	5,512,625	04/30/1996	Butterbach et al.	524	490	
	GX	5,563,222	10/08/1996	Fukuda et al.	525	347	
	GY	5,601,858	02/11/1997	Mansukhani et al.	426	3	
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	HA	5,663,230	09/02/1997	Haman	524	447	
	HB	5,683,634	11/04/1997	Fujii et al.	264	41	
	HC	5,683,815	11/04/1997	Leiss	428	424.4	
	HD	5,688,850	11/18/1997	Wyffels	524	317	
	HE	5,726,239	03/10/1998	Maes et al.	524	505	
	HF	5,728,760	03/17/1998	Rose et al.	524	292	
	HG	5,736,197	04/07/1998	Gaveske	427	393	
	HH	5,739,200	04/14/1998	Cheung et al.	524	504	
	HI	5,741,840	04/21/1998	Lindquist et al.	524	271	
	HJ	5,747,573	05/05/1998	Ryan	524	270	
	HK	5,786,418	07/28/1998	Strelow et al.	524	579	
	HL	5,789,529	08/04/1998	Matsumura et al.	528	310	
	HM	5,804,630	09/08/1998	Heyer et al.	524	436	
	HN	5,837,769	11/17/1998	Graafland et al.	524	505	
	HO	5,849,806	12/15/1998	St. Clair et al.	521	109.1	
	HP	5,869,555	02/09/1999	Simmons et al.	524	229	
	HQ	5,869,560	02/09/1999	Kobayashi et al.	524	407	
	HR	5,869,562	02/09/1999	Lindquist et al.	524	505	
	HS	5,872,183	02/16/1999	Bonnet et al.	525	66	
	HT	5,908,412	06/01/1999	Beger Koczalski et al.	604	367	
	HU	5,916,959	06/29/1999	Lindquist et al.	524	505	
	HV	5,929,147	07/27/1999	Pierick et al.	524	99	
	HW	5,939,483	08/17/1999	Kueppers	524	407	
	HX	5,948,557	09/07/1999	Ondeck et al.	429	33	
	HY	6,001,455	12/14/1999	Nishio et al.	428	156	
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HA	HZ	6,017,986	01/25/2000	Burton	524	313	
	IA	6,027,674	02/22/2000	Yates	64	113	
	IB	6,045,922	04/04/2000	Jannssen et al.	428	515	
	IC	6,060,561	09/09/2000	Wolfshwenger et al.	525	159	
	ID	6,077,899	06/20/2000	Yatsuyanagi et al.	524	495	
	IE	6,084,031	07/04/2000	Medsker et al.	525	192	
	IF	6,086,996	07/11/2000	Rancich et al.	428	355EN	
	IG	6,127,444	10/03/2000	Kadri	521	139	
	IH	6,143,818	11/07/2000	Huang et al.	524	528	
	II	6,190,769	02/20/2001	Wang	428	392	
	IJ	6,194,498	02/27/2001	Anderson et al.	524	168	
	IK	6,231,936	05/15/2001	Kozimor et al.	428	34.7	
	IL	6,231,970	05/15/2001	Anderson et al.	428	332	
	IM	6,271,294	08/07/2001	Lasson et al.	524	314	
	IN	6,316,068	11/13/2001	Masubuchi et al.	428	35.7	
	IO	6,326,426	12/04/2001	Ellul	524	290	
	IP	6,329,468	12/11/2001	Wang	525	240	
	IQ	6,337,364	01/08/2002	Sakaki et al.	524	270	
	IR	6,342,209	01/29/2002	Patil et al.	424	61	
	IS	6,342,320	01/29/2002	Liu et al.	429	307	
	IT	6,342,565	01/29/2002	Cheng et al.	525	191	
	IU	6,348,563	02/19/2002	Fukuda et al.	528	310	
	IV	6,362,252	03/26/2002	Prutkin	523	200	
	IW	6,372,379	04/16/2002	Samii et al.	429	45	
	IX	6,380,292	04/30/2002	Gibes et al.	524	318	
EXAMINER				November 21, 2005			
*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next comment to applicant.							

INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)				ATTY. DOCKET NO.	SERIAL NO.		
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				Chon-Yie Lin, et al.			
				FILING DATE	GROUP		
				August 04, 2003	1711		
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	IZ	6,410,200	06/25/2002	Williams et al.	420	126	
	JA	6,413,458	07/02/2002	Pearce	264	141	
	JB	6,448,338	09/10/2002	Born et al.	525	193	
	JC	6,451,915	09/17/2002	Ellul et al.	525	191	
	JD	6,465,109	10/15/2002	Ohtsuka	428	516	
	JE	6,482,281	11/19/2002	Schmidt	156	108	
	JF	6,509,128	01/21/2003	Everaerts et al.	430	39	
	JG	6,531,214	03/11/2003	Carter et al.	428	336	
	JH	6,538,066	03/25/2003	Watanabe et al.	525	184	
	JI	6,559,232	05/06/2003	Inoue et al.	525	240	
	JJ	6,583,207	06/24/2003	Stanhope et al.	524	291	
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	JL	6,623,847	09/23/2003	Yates	428	344.4	
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	JN	6,730,739	05/04/2004	Gipson	525	191	
	JO	6,867,253	03/15/2005	Chen	524	505	
	JP	2001/0051265	12/13/2001	Williams et al.	428	343	
	JQ	2002/0049276	04/25/2002	Zwick	524	476	
	JR	2002/0077409	06/20/2002	Sakaki et al.	524	496	
	JS	2002/0147266	10/10/2002	Rawlinson et al.	524	525	
	JT	2002/0155267	10/24/2002	Bader	428	216	
	JU	2002/0160137	10/31/2002	Varma	428	35.7	
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	JW	2003/0004266	01/02/2003	Kitazaki et al.	525	95	
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<p>*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next comment to applicant</p>							

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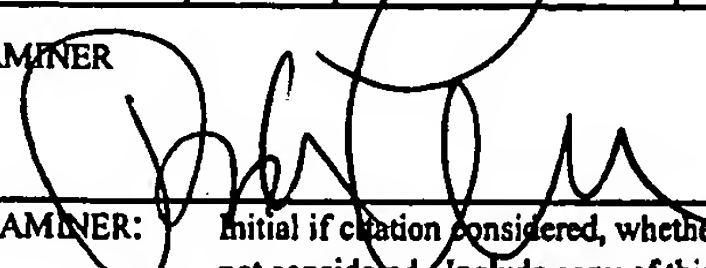
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	JY	2003/0032696	02/13/2003	Sime et al.	523	160	
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	KD	2003/0187081	10/02/2003	Cui	521	29	
	KE	2003/157859	08/21/2003	Ishikawa	442	340	
	KF	2004/214498	10/28/2004	Webb et al.	442	329	
	KG	2004/0034148	02/19/2004	Kelly et al.	524	474	
	KH	2004/0070653	04/15/2004	Mashita et al.	347	86	
	KI	2004/106723	06/03/2004	Yang et al.	524	570	
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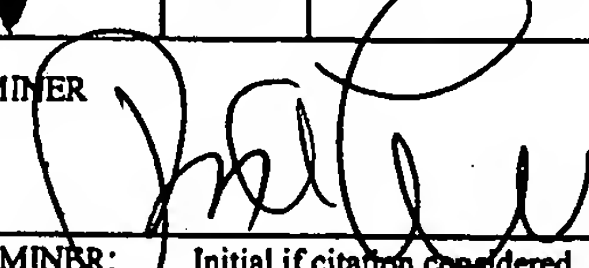
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EXAMINER <i>[Signature]</i>	DATE CONSIDERED <i>June 21, 2005</i>
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	LA	0 299 718	01/18/1989	EP			
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LG	0 321 868	06/28/1989	EP				
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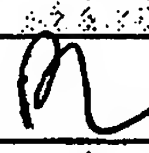
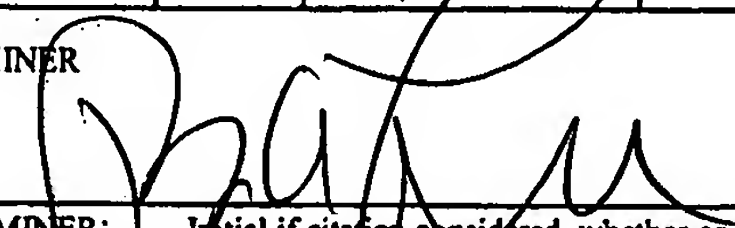
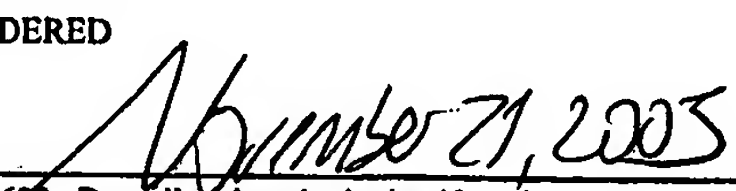
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	MC	0 083 049	07/06/1983	EP				
	MD	0 801 104	10/15/1997	EP Abstract Attached				X
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	MG	1 028 145	08/16/2000	EP				
	MH	1 104 783	06/06/2001	EP Abstract Attached				X
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	MJ	1 211 285	06/05/2002	EP				
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	MO	1566388	03/31/1969	FR Abstract Attached			X
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	MR	2 110 824	06/02/1972	FR			X
	MS	2.212.382	07/26/1974	FR			X
	MT	2 256 207	12/26/1974	FR			X
	MU	2 272 143	05/21/1975	FR			X
	MV	2 590 910	06/05/1987	FR			X
	MW	2 602 515	02/12/1988	FR			X
	MX	964 845	07/22/1964	GB			
	MY	1,044,028	09/28/1966	GB			
	MZ	1,044,502	10/05/1966	GB			
	NA	1,044,503	10/05/1966	GB			
	NB	1,166,664	10/08/1969	GB			
	NC	1,252,638	11/10/1971	GB			
	ND	1,329,915	09/12/1973	GB			
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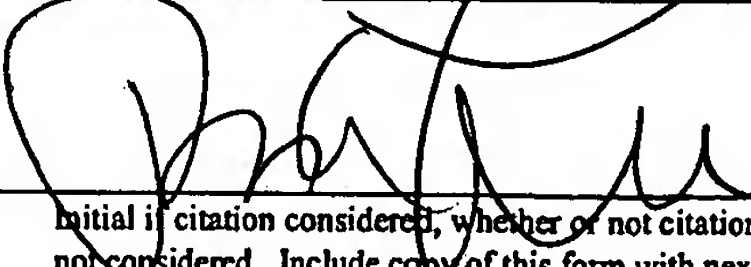
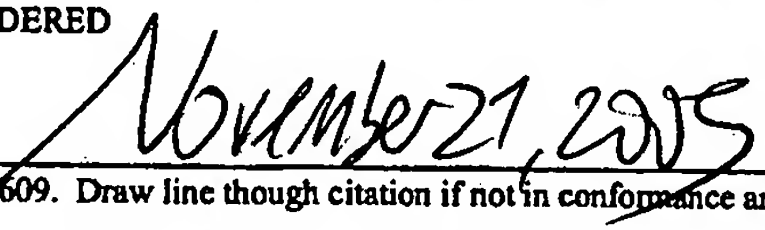
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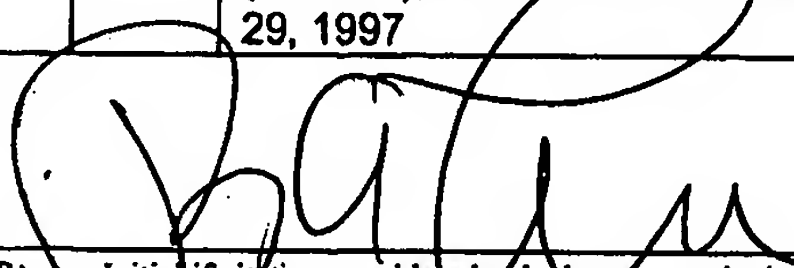
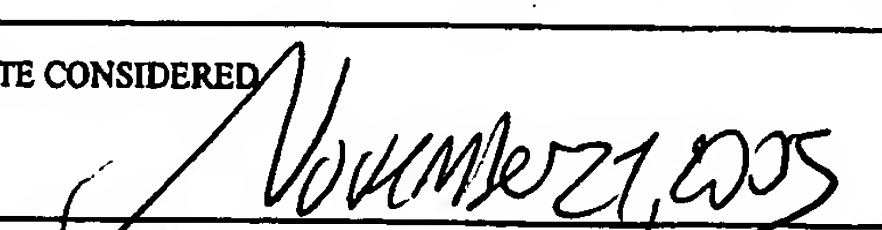
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EXAMINER				DATE CONSIDERED			
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<p>*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next comment to applicant</p>							

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	QS	01/43963	06/21/2001	WO				
	QT	01/18109	03/15/2001	WO				
	QU	02/10310	02/07/2002	WO Abstract attached				X
	QV	02/17973	03/07/2002	WO				
	QW	02/30194	04/18/2002	WO				
	QX	02/062891	08/15/2002	WO				
	QY	02/072689	09/19/2002	WO Abstract attached				X
	QZ	02/074873	09/26/2002	WO				
	RA	02/18487	03/07/2002	WO				
RB	02/31044	04/18/2002	WO					
RC	03/048252	06/12/2003	WO					
RD	04/009699	01/29/2004	WO					
EXAMINER				DATE CONSIDERED				
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INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)				ATTY DOCKET NO.		SERIAL NO.		
				2002B107A		10/634,351		
				APPLICANT				
				Chon-Yie Lin, et al.				
FILING DATE				GROUP				
August 04, 2003				1711				
U.S. PATENT DOCUMENTS								
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
	RE	4,132,698	01/02/79	Gessler et al.				
	RF	4,274,932	06/23/81	Williams et al.				
	RG	4,369,284	01/18/83	Chen				
	RH	4,460,729	07/17/84	Books				
	RI	4,467,065	08/21/84	Williams et al.				
	RJ	4,666,959	05/19/87	Weissberger et al.				
	RK	4,749,734	06/07/88	Williams et al.				
	RL	4,959,402	09/25/90	Williams et al.				
	RM	5,258,419	11/02/93	Rolando et al.				
	RN	5,356,709	10/18/94	Woo et al.				
	RO	5,356,948	10/18/94	Payne, Jr. et al.				
	RP	5,376,716	12/27/94	Nayak et al.				
FOREIGN PATENT DOCUMENTS								
		DOCUMENT NUMBER	PUBL. DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
	RQ	32 44 499	06/16/83	DE				X
	RR	37 35 502	05/03/98	DE				X
	RS	0 614 939	09/14/94	EP				
	RT	0 664 315	07/26/95	EP				
OTHER DISCLOSURES (Including Author, Title, Date, Pertinent Pages of Publication, Etc.)								
EXAMINER					DATE CONSIDERED			
								
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				FILING DATE		GROUP	
				August 04, 2003		1711	
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	PUBL. DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
m	RW	02/088238	11/07/2002	WO	Abstract attached		X
	RX	02/18487	03/07/2002	WO			
	RY	02/31044	04/18/2002	WO			
	RZ	03/029379	04/10/2003	WO	Abstract attached		X
	SA	03/048252	06/12/2003	WO			
	SB	03/060004	07/24/2003	WO	Abstract attached		X
	SC	03/066729	08/14/2003	WO	Abstract attached		X
	SD	04/014997	02/19/2004	WO			
	SE	04/20195	03/11/2004	WO			
	SF	04/31292	09/26/2003	WO			
OTHER DISCLOSURES (Including Author, Title, Date, Pertinent Pages of Publication, Etc.)							
m	SG	Abstract of JP 8253754, published on 10/01/96, entitled, "Method for Foaming Reactive Hot-Melt Polyurethane Adhesive"					
	SH	PCT Written Opinion, 01/07/04, 2002B107B					
	SI	"Swelling Interaction, Plasticization, and Antioxidant extraction Between Fiber Optic Cable Gels and Polyolefins" B. G. Risch, Ph.D., SPE-ANTEC, 1999					
	SJ	"Use of "Clean" Paraffinic Processing Oils to Improve TPE Properties", B. J. Gedeon et al., TPEs, 2000, pp. 157-170					
	SK	"Plasticizing of isotactic polypropylene upon addition of hydrocarbon oils", K. Nitta et al., e-Polymers, no. 021, 2004, pp. 1 - 11					
	SL	"The Effect of Oil Type and Content on the Rheological, Mechanical and Thermal Properties of a Polyolefinic Based Thermoplastic Elastomer", McShane, et al. SPE-ANTEC, 2002					
	SM	Abstract of "Plasticizing Characteristics of High-Density Polyethylene" Wu et al., Suliao, 1988, 17 (4), 3 - 8					
	SN	Abstract of "Effect of Technological Additives on Properties of Thermoplastic vulcanizates Based on Ethylene Propylene Rubber and Polyolefins" Kanauzov et al., Kauchuk i Rezina, 2000, (4), 12 - 15					
	SO	Abstract of Polybutenes: a versatile modifier for plastics, J. D. Fotheringham, AddCon Asia (RAPRA), International Plastics Additives and Modifiers Conference, Singapore, October 28-29, 1997					
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		August 04, 2003	1711
OTHER DISCLOSURES (Including Author, Title, Date, Pertinent Pages of Publication, Etc.)			
<i>M</i>	SP	Abstract of "Effect of Petroleum Plasticizers and Synthetic Oils on Rheological and service Properties of Polyolefins", M.D. Nasibova et al., Olefinov s Opyt. Z-dom, 1991 (14), 60-6	
<i>M</i>	SQ	"Rubber Chemicals and Additives", Rubber Technology Handbook, 1989, Werner Hoffman, Hanser Publishers, New York, pp. 294-305	
<i>M</i>	SR	"Plasticizers", Additives for Plastics, J. Stepek, H. Daoust, 1983, Springer Verlag, New York, pp. 6-69	
<i>M</i>	ST	"Lubricants and Other Processing Aids", Chemical Additives for the Plastics Industry, Properties, Applications, Toxicologies, Noyes Data Corporation, Park Ridge, NJ, 1987, pp. 1073116	
	SU	"Synthetic Lubricants and High-Performance Functional Fluids: Chemistry, Technology, and Commercial Importance", "Polybutenes", Second Edition, Rudnick, Shubkin, eds., Marcel Dekker, Inc. New York, 1999, pp. 1-52, 357-392	
EXAMINER		DATE CONSIDERED	
<i>[Signature]</i>		<i>November 21, 2005</i>	
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